MTM86124

Silicon P-channel MOS FET

For DC-DC converter circuits For switching circuits

Overview

MTM86124 is the P-channel MOS FET that is highly suitable for DC-DC converter and other switching circuits.

■ Features

• Low ON resistance: $R_{on} = 100 \text{ m}\Omega (V_{GS} = 4.0 \text{ V})$

• Low short-circuit input capacitance (common source): $C_{iss} = 400 \text{ pF}$

• Small package: WSSMini6-F1 (1.6 mm × 1.6 mm × 0.5 mm)

• Low drive voltage: 2.5 V drive

■ Absolute Maximum Ratings $T_a = 25$ °C

Parameter	Symbol	Rating	Unit	
Drain-source surrender voltage	V _{DSS}	-20	V	
Gate-source surrender voltage	V _{GSS}	±10	V	
Drain current	I _D	-2.0	A	
Peak drain current *1	I _{DP}	-8	A	
Power dissipation *2	P_{D}	540	mW	
Channel temperature	T _{ch}	150	5° ℃	
Storage temperature	T _{stg}	-55 to +150	°C	

Note) *1: Pulse width ≤ 10 µs, Duty cycle ≤ 1%

*2:Measuring on ceramic substrate at 40 mm \times 38 mm \times 0.2 mm P_D absolute maximum rating without a heat shink: 150 mW

■ Package

Code

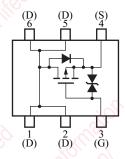
WSSMini6-F1

Pin Name

1: Drain 4: Source 2: Drain 5: Drain 3: Gate 6: Drain

■ Marking Symbo: DM

■ Internal Connection



■ Electrical Characteristics $T_a = 25$ °C±3°C

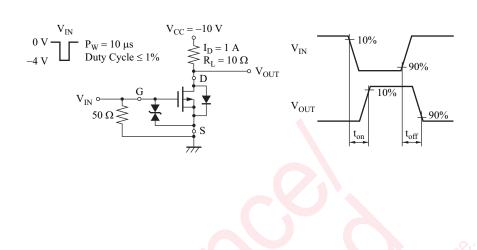
Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Drain-source surrender voltage	V _{DSS}	$I_D = -1 \text{ mA}, V_{GS} = 0$	-20			V
Drain-source cutoff current	I_{DSS}	$V_{\rm DS} = -20 \text{V}, V_{\rm GS} = 0$			-1.0	μΑ
Gate-source cutoff current	I_{GSS}	$V_{GS} = \pm 8 \text{ V}, V_{DS} = 0$			±10	μΑ
Gate threshold voltage	V_{TH}	$I_D = -1.0 \text{ mA}, V_{DS} = -10 \text{ V}$	-0.4	-0.85	-1.3	V
Drain-source ON resistance 1 *1	R _{DS(on)} 1	$I_D = -1 \text{ A}, V_{GS} = -4.0 \text{ V}$		100	130	mΩ
Drain-source ON resistance 2 *1	R _{DS(on)} 2	$I_D = -0.6 \text{ A}, V_{GS} = -2.5 \text{ V}$		130	200	mΩ
Forward transfer admittance*1	Y _{fs}	$I_D = -1.0 \text{ A}, V_{DS} = -10 \text{ V}, f = 1 \text{ kHz}$	3.0			S
Short-circuit input capacitance (Common source)	C _{iss}			400		pF
Short-circuit output capacitance (Common source)	C _{oss}	$V_{DS} = -10 \text{ V}, V_{GS} = 0, f = 1 \text{ MHz}$		40		pF
Reverse transfer capacitance (Common source)	C _{rss}			35		pF
Turn-on time *2	t _{on}	$V_{DD} = -10 \text{ V}, V_{GS} = 0 \text{ V to } -4 \text{ V}, I_D = -1 \text{ A}$		15		ns
Turn-off time *2	t _{off}	$V_{DD} = -10 \text{ V}, V_{GS} = -4 \text{ V to } 0 \text{ V}, I_D = -1 \text{ A}$		100		ns

Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

- 2. *1: Pulse measurement
 - *2: Test circuit

MTM86124 Panasonic

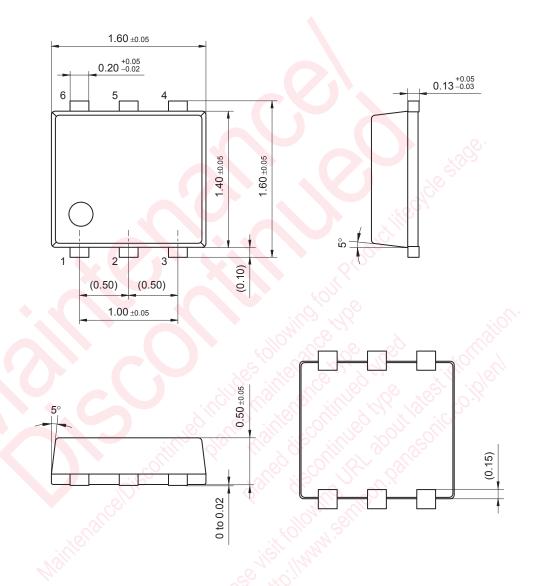
Test circuit



2 SJF00083AED

WSSMini6-F1

Unit: mm



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